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**RESEARCH REPORT**  
NIFS Series

## Recovery of Cesium in the Hydrogen Negative Ion Sources

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### Abstract.

Cesium recovery from the polluted layers in the 1/3 scale hydrogen negative ion source for LHD-NBI system has tested. It was found, that the cesium recovery can be produced by additional discharges as from the cesium layer, aged by tungsten and residual gas, so as from the cesium layers, polluted by an occasional water leak. The highest cesium recovery to NI production was produced by a xenon arc, while glow discharge and arcing in hydrogen were less effective. The mechanism of recovery is the ejection of cesium from the underlying enriched layer by the arc and its transport to the surface.

Keywords: hydrogen negative ion, recovery of cesium, ion source, NBI, Cs-W

A number of multicusp negative ion sources developed for neutral beam injection into fusion devices have explored seeding of cesium<sup>1</sup>. Most of the seeded cesium in the developed versions of the multicusp sources is buried with the evaporated tungsten on the water-cooled internal surfaces of gas-discharge box<sup>2</sup>. It seems important to recover the cesium, buried on the discharge chamber walls instead of just additional feed. We have tested the cesium recovery from the polluted layers by additional discharges in the 1/3 scale hydrogen negative ion source for LHD-NBI system. The results of cesium recovery experiments are described below.

### Experimental Setup

In cesium recovery experiments, an External-filter-type 1/3 scale Multicusp NI source (EMS) was used, which has been developed for high-energy and high-current NI beam production<sup>1</sup>. The tungsten filaments are used in the source for electron emission. A direct deposition of cesium was done to EMS inner walls with a small movable oven<sup>2</sup>. There are three grids used for H beam extraction and acceleration - Plasma Grid (PG), extraction grid and grounded grid. The PG has 270 apertures of 9 mm in diameter. The ion source is attached to the NBI test stand<sup>1</sup>. The H beam acceleration up to 90 keV with beam pulse duration 0.6-1.3 s was used. A multichannel calorimeter, located 11.2 m downstream from the ion source is used for H ion current measurement. About 2.5 A H current produced with the 1/3 scale source at 50 kW arc power is to be scaled up to 40 A H yield for the full-scale source<sup>1</sup>.

Cesium recovery was produced by an additional discharges during the 30-60 min pause in EMS operation. For recovery of cesium on the Plasma Chamber (PC) wall the last one was acting as a cathode of additional discharge. PG surface recovery was done with PG acting as a cathode. A 0.4-0.6 kV voltage provides the xenon glow ignition. A glow-to-arc transition occurs with the glow current increase, and a pulsed arc discharges were supported in the xenon or hydrogen. The arc current and pulse duration were depended on cesium coverage thickness and were decreased with the cesium depletion. A regular EMS discharge in hydrogen and xenon, using an electron emission from the EMS filaments was also tested for cesium recovery. The PC or PG was biased to the cathode potential during this PC or PG processing by the EMS discharge. A special electrodes were introduced onto the PC wall for ignition the vacuum arc. Attempts to ignite the vacuum arc on the cesiated PC surface were launched after the 0.1 g cesium deposition by cesium plasma, but they failed.

### Cesium recovery from Cs-W coverage

A. Deposition of small cesium amount into the EMS produces the temporal increase of H current for several pulses of source operation<sup>2</sup>. Fig.1 shows the evolution of H current from shot to shot (triangles, left scale), and arc power of shot (circles, right scale) in the case of 10 mg cesium deposition and its processing by an additional discharges. H current was increased to a value of 1.3 A after the cesium deposition to PC back (done before the shot # 60) and it was decreased with the further operation due to cesium blocking (Fig. 1).

An attempt to recover the blocked cesium by a xenon glow was done before the shot # 89 in Fig. 1. A dc glow (0.3 kV/0.5 A) at xenon pressure 0.5 Pa was applied during about 20 minutes with PC acting as a cathode. A negligible change of H yield was recorded after this (shots # 95-98 in Fig. 1). The next processing was done with PC acting as an arc cathode (PC arcing). About 10<sup>2</sup> pulsed arcs were ignited at xenon pressure 0.8-1.5 Pa before shots #98. It results in a temporal increase of H current to 0.5 A value, but then H current was decreased fast (Fig. 1). PG processing with PG acting as an arc cathode (PG arcing) was done then. About 10<sup>2</sup> pulsed arcs were ignited with the PG having a cathode potential at xenon pressure 1.5 Pa before shot #110. No improvement of H yield was recorded after PG arcing (Fig. 1). Fig. 1 shows, that cesium recovery is inefficient in the case of small cesium deposition.

B. Deposition of 0.1-0.2 g Cs portions while using an optimal amount of filaments in the discharge demonstrates the stable enhancement of H yield for a longer period of source operation<sup>2</sup>. Namely, 0.1 g deposition provides the increase of H beam current to 2.8 A value, and it was slowly degraded down to 2 A level in 500 shots/2 days of operation. The next 0.15 g deposition produces the 2.8 A level of H current and it was decreased down to 1.7 A during 600 shots/4 days operation (at discharge power about 50 kW, hydrogen pressure 0.7 Pa, 8 filaments). Several types of additional discharges were tested for H production recovery after this cesium blocking. Fig. 2 show the H current evolution before and after these EMS processing (triangles, left scale), and an arc power of corresponding shot (circles, right scale).

1. PC arcing was produced at xenon pressure of about 0.7 Pa before shot #1232. After producing about 2·10<sup>2</sup> pulsed arcs (20-30 A, 5-15 msec) the H production was tested again. H current was increased up to 2.3 A with the PG temperature growth to 160-170 °C, and it was decreased to the previous value 1.7 A during the further 50 shots/ 2 hours operation (Fig. 2). No one breakdown happened during the source high-voltage operation after the cesium recovery processing in xenon.

2. Attempt to recover the cesium-tungsten layer on PG surface was done by the PG biasing to the cathode potential while the source was operated in the regular EMS arc mode with hydrogen feed and electron emission from heated filaments. After producing the 9 pulses with PG at cathode bias (arc power 5-10 kW, shots # 1287-95 in Fig. 2) the H production was checked again. H yield had a value of 0.8 A at PG starting temperature 80 °C, it was increased to 1.5 A level with the PG temperature growth to 220 °C, and had no change with the further operation and PG heating up to 260 °C (Fig. 2). No temporal peak of H production was recorded

in this case The H current steady-state level was about 0.2 A lower, than it was before the PG processing with PG cathode biasing in the EMS regular arc!

3. The processing by the regular EMS arc with the PC biasing to the cathode potential was tested next. The arc in xenon was used, since an attempt to ignite the arc in hydrogen with the PC biasing to the cathode was failed. 13 pulses of EMS regular arc (40-60 A/60 V) were produced at xenon pressure 0.7 Pa. The H yield had about the same value after this PC processing, as it was before.

4. About  $2 \cdot 10^2$  pulsed arcs were produced during the PC arcing at hydrogen pressure 5-10 Pa. The H beam current had about 7-10% increased value after PC arcing in hydrogen, and it was degraded down to the previous value after 50 shots/2 hours operation.

5. About 30 minute PC processing as a cathode of 1 kV/ 1-3 mA dc glow in hydrogen had no changed the H yield.

6. About  $2 \cdot 10^3$  pulsed arcs (10-20 A, 40-80 V, 5-20 msec) were produced during the next PC arcing at xenon pressure 0.5-3 Pa. This more intense PC arcing results in a more steady 30% H yield increase and the following slower decrease down to the previous value during the 70 shot/2.5 hours operation. The next intense PC arcing was applied after an additional 0.1 g cesium deposition to PC and its aging by a 400 shot/3 day operation. About  $10^3$  pulsed arcs (20-30 A, 30-75 V, 5-10 msec) were produced at xenon pressure 0.7 Pa. It resulted in a steady 25% increase of H current up to 2.5 A level with a following slow decrease down to the previous value during about  $10^2$  shot /3 hours offurther operation. A 30% H current increase to 2.2 A level was recorded after the next PC arcing, produced 3 days later. Several intense PC arcings provide the steady 25-30% H yield enhancement, but H current absolute value was higher after arcing of EMS coverage, enriched by cesium.

#### Cesium recovery from a water-polluted layer

The cesium recovery from the cesium-tungsten layer, polluted by an occasional water leak was tested as well. About 0.6 g of cesium was deposited to the PC surface during 700 shots of EMS operation, preceding the occasional water leak. The evolution of H beam current due to cesium recovery procedures from the water-polluted layer is shown in Fig.3. The H beam current had a value of 0.5 A at arc power 50 kW and gas filling pressure 0.7 Pa after the source pollution with a water leak. This value was about 20-30% higher, than H yield from the pure hydrogen discharge.

About  $10^3$  pulsed arcs with the PG as an arc cathode, and then about  $5 \cdot 10^2$  pulsed arcs with the PC as an arc cathode were produced at xenon pressure 1.5 Pa. After this processing, done before the shot #1 in Fig.3, the H current was increased up to 1.1 A at the  $10^{\text{th}}$  shot, and then was decreased to the previous value 0.5 A after about 20 shots/ 40 min of operation. The next PC and/or PG arcing processing in xenon displayed approximately the same evolution of H current (Fig.3). The second PC arcing ( $10^3$  arc pulses) was done before shot # 35 at xenon pressure 2 Pa. The increase of H current up to 1.4 A level was displayed (shot #48 in Fig.3). After about

$5 \cdot 10^3$  arcs produced with PG biased to the cathode potential (before shot #56) the H current was increased to a maximal value 1.2 A (shot #66). The next arcing processing, produced on the water-polluted PC and PG surface (before shot #78) have resulted in the same temporal increase of H current to 1.1 A (shots #86-92). PG optimal temperature was about 140-190 °C at H current maximum. No trace of electrode erosion by PC/PG multiple arcing was detected on EMS surfaces after the source evacuation to atmosphere.

The listed data shows, that several arcing processing on water-polluted electrodes produces the same temporal 2-fold enhancement of H yield, but does not recover the optimal cesium-tungsten coverage on PG surface completely. As a result, the H current maximum after the water-polluted electrodes processing was about two times less, than that after a thick Cs-W coverage arcing. The enhanced H yield degraded 2-3 times faster after the water-polluted electrode recovery (or after cesium adding to water-polluted electrodes<sup>2</sup>), as compared with that after the Cs-W coverage arcing. It shows, that cesium deposited on the water-polluted layer provides a smaller replenishment flux to PG surface.

## DISCUSSION

The data obtained evinces the cesium blocking on the PC/PG walls and its recovery for H production by an additional discharge processing. The highest cesium recovery were produced by arcing in xenon, while arcing in hydrogen and processing by glow were less effective. The principle of cesium recovery by arcs is the decomposition of cesium compound, the cesium ejection from the underlying layer and the renewal of the cesium coverage on EMS surfaces. The internal layer of Cs-W reservoir are enriched by cesium, so the arc ejection of electrode material increases the percentage of cesium in the coverage. An arc ejects of about 1 atom of cathode material per 10 cathode emitted electrons, so the EMS processing with  $10^3$  arcs ( $10^{-2}$  s, 30 A) evaporates of about 30 mg of Cs-W coverage. Cesium recovery is less efficient for a higher tungsten percentage in the coverage.

PC arcing can produce the Cs<sup>+</sup> ion implantation to PG coverage with positive ion flux to the arc anode. The ejection of the overlaid tungsten by arcing and the tungsten sputtering by glow is also important for the improvement of cesium seed from the buried layer.

Our data demonstrates the importance of optimal PG coverage structure for H production enhancement. A minute PG processing by a regular EMS hydrogen discharge with PG biasing to the cathode produces a sizable decrease of H current (Fig.2). It can be caused by H production decrease due to Cs-W coverage loading with energetic hydrogen ions<sup>3</sup>. The pollution of Cs+W coverage by a water leak increases the PG work function and stops the replenishment flux to PG. It decreases the H production down to about pure hydrogen level.

The cesium recovery can be produced by vacuum arcing on the thick Cs-W coverage. Vacuum arc supplies an intense (10% of arc current) flux of energetic positive ions to the anode and can produce Cs<sup>+</sup> ion

implantation to PG coverage. The H extraction voltage applying during the arcing will prevent the Cs<sup>+</sup> flux to the extraction gap. It is proposed to support the cesium recovery *in situ* by applying the pulsed arcing/glowing within the pause between the injector pulses.

Cesium recovery processing in xenon produces an easy flux of cesium to PG surface and does not decrease the electrical strength of extraction/acceleration gaps. The xenon filling to PC during the standard cesium deposition procedure can also decrease the cesium flux to accelerator and to improve the high-voltage holding-on of the EMS. The cesiated hollow cathodes or RF discharge can be used instead of the hot tungsten filaments for EMS feeding with plasma.

### SUMMARY

Optimal PG cesium coverage structure is important for H production enhancement. Cesium blocking by evaporated tungsten decreases the H yield from the EMS. Electrode processing by an additional discharge recovers the H production. The mechanism of recovery is the ejection of cesium from the underlying enriched layer by arc and its transport to the surface. Recovery processing permits the use of deposited cesium more efficiently and to minimize cesium addition during the EMS longterm operation.

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## Figure Captions

Fig 1. H- current evolution after 10 mg Cs deposition and PC/PG arcing.

Fig.2 H- current evolution after PC arcing and after PG processing by EMS discharge in hydrogen.0.25 g cesium deposited

Fig.3. H- current evolution after water-polluted electrodes arcing.

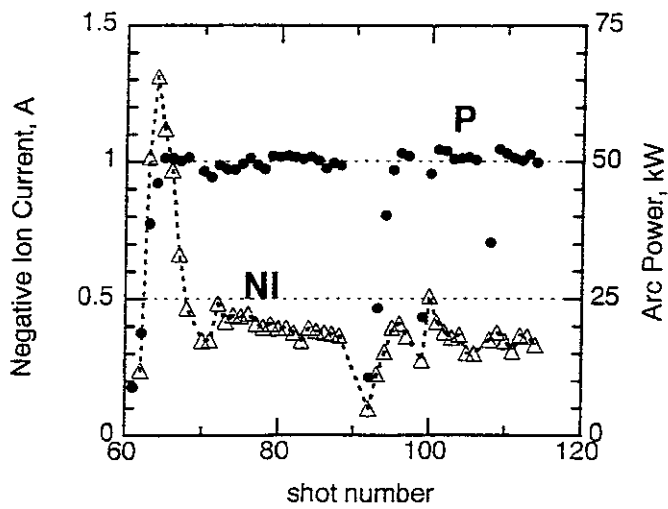


Fig.1. H- current evolution after 10 mg Cs deposition and PC/PG arcing

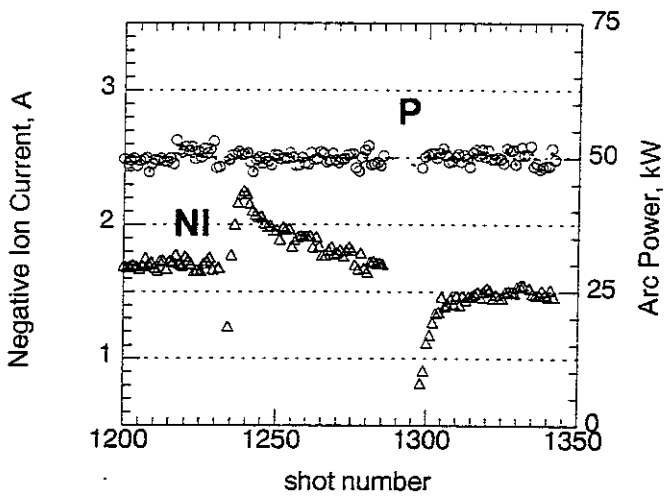


Fig.2. H- current evolution after PC arcing and after PG processing by EMS discharge in hydrogen.0.25 g cesium blocked.

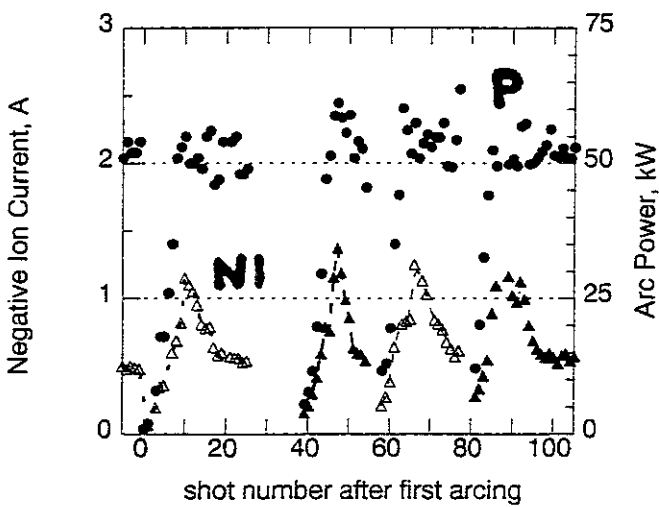


Fig.3 H- current evolution after water-polluted electrodes arcing

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